#### 1 Revision2

2	High-temperature structural change and microtexture formation of sillimanite and its
3	phase relation with mullite
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14	Abstract
15	Synchrotron powder X-ray diffraction (XRD) experiments and transmission electron
16	microscopy (TEM) observations of heat-treated sillimanite at various pressures were
17	conducted to clarify the detailed phase relation between sillimanite and mullite. Under
18	TEM, heat-treated sillimanite frequently showed anti-phase boundary (APB)-like textures

with a displacement vector of 1/2[001]<sub>sil</sub>. Additional scanning TEM-energy dispersive 19 20X-ray spectroscopy analysis of regions with APB-like texture showed that they were clearly enriched in Al and accompanied by very fine, Si-rich glass inclusions, which indicates that 21the APB-like textures are composed of fine mullite. Moreover, synchrotron XRD patterns 22of these samples clearly showed double peaks of newly formed mullite and remnant 23sillimanite, indicating that the compositional transformation from sillimanite to mullite and 2425glass is discontinuous. We separately determined the cell parameters of the sillimanite and 26mullite from the XRD pattern and found that the b axial length of the sillimanite increased 27with the treatment temperature, reflecting disordering of tetrahedral Al and Si in the 28sillimanite. In contrast, the positions of the deconvoluted mullite peaks indicated that the a 29axial length of mullite decreased as experimental pressure increased, owing to enrichment 30 of the Si component. By projecting the cell parameters onto the a-b axial plane, the detailed changes in the crystallographic state of the sillimanite and mullite could be easily 3132and comprehensively identified. On the basis of our results, we propose a new P-T diagram 33 for the Al<sub>2</sub>SiO<sub>5</sub> system that shows the transformation boundary between sillimanite and 34mullite + SiO<sub>2</sub>-rich melt and the contour of the Al/Si order parameter of sillimanite.

35 Keywords: sillimanite, mullite, high-temperature phase relation, TEM observation,

36 synchrotron X-ray experiment

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#### Introduction

Naturally occurring polymorphs of  $Al_2SiO_5$  (andalusite, kyanite, sillimanite) have assumed a special significance for geologists because of their abundance in metamorphic rocks and their simple pressure–temperature (*P*–*T*) phase relations. Although the phase relations in this system have been investigated over many years, however, some problems persist, in particular, related to sillimanite.

The crystal structure of sillimanite [space group *Pbnm* (No. 62)] is characterized by 4445chains of edge-sharing  $AlO_6$  octahedra (AlO<sub>4</sub> octahedral chains) linked to double 46  $SiO_4/AIO_4$  tetrahedral chains parallel to the *c*-axis, with the  $SiO_4$  and  $AIO_4$  tetrahedra 47arranged alternately. Zen (1969) considered that disordering of this tetrahedral Al and Si 48arrangement in sillimanite might be an important factor leading to complications of the 49Al<sub>2</sub>SiO<sub>5</sub> phase equilibria. Subsequently, other researchers (e.g., Holdaway 1971; Greenwood 1972; Saxena 1974) have also suggested that Al/Si disordering in sillimanite, 5051which increases the configuration entropy, might have important effects on the phase 52relations of Al<sub>2</sub>SiO<sub>5</sub> polymorphs.

Navrotsky et al. (1973) experimentally detected an enthalpy difference between untreated sillimanite and sillimanite heated at 1200–1700 °C under pressures of 1.6–2.3 GPa that they inferred to reflect Al/Si disordering. However, Holland and Carpenter (1986), using transmission electron microscopy (TEM), observed small glass inclusions in sillimanite samples heat-treated under conditions similar to those used by Navrotsky et al. (1973). They inferred that some transformation related to mullite  $[Al_2(Al_{2+2x}Si_{2-2x})O_{10-x},$ where x = 0.17-0.59 (Cameron 1977), space group *Pbam* (No. 55)], which is more Al-rich 60 than sillimanite, had occurred as a result of partial melting at high temperatures, and that 61 the enthalpy change detected by Navrotsky et al. (1973) might in part reflect the appearance 62 of similar fine glass inclusions. These results imply that experimental investigation of the 63 degree of Al/Si order in sillimanite at high temperatures is not simple; rather, careful 64 differentiation between sillimanite and mullite, including glass phases, is very important.

However, sillimanite and mullite are difficult to distinguish because of the similarity of their crystal structures. Mullite has the same basic framework as sillimanite (i.e.,  $AIO_4$ octahedral chains and double  $SiO_4/AIO_4$  tetrahedral chains), and its structure differs from that of sillimanite only by the disordered distribution of A1 and Si in the tetrahedra and the existence of an additional tetrahedral site, which is coupled to the occurrence of oxygen vacancies (e.g., Fischer et al., 2012). In fact, Burnham (1963) reported that only a few atoms need to be slightly shifted or removed to create one phase from the other.

Moreover, the exact phase relation and the *P*–*T* boundary between the two phases is still not clear. Some researchers (e.g., Hariya et al. 1969) have suggested that there may be a complete solid solution series between sillimanite and mullite under certain high temperature and high pressure conditions, although it is relatively accepted that a miscibility gap exists at around  $0.04 < x \le 0.17$  in Al<sub>2</sub>(Al<sub>2+2x</sub>Si<sub>2-2x</sub>)O<sub>10-x</sub> (Cameron 1977). In addition, Fischer et al. (2015) newly reported a natural mineral, "sillimullite" that is intermediate between silimanite and mullite but different to both of them.

Furthermore, there are large inconsistencies among previous estimates of the phase boundary position on the P-T diagram (e.g., Holm and Kleppa 1966; Weill 1966; Kiseleva et al. 1983). The ambiguities regarding the phase relation between sillimanite and mullite have prevented precise phase identifications and inhibited further investigations of Al/Si
disordering in sillimanite.

Recently, Igami et al. (2017), using a synchrotron X-ray and high-resolution 84 multiple-detector system developed by Toraya et al. (1996), successfully distinguished the 85 86 X-ray diffraction (XRD) peaks of sillimanite and mullite in mixtures of these two minerals. In this study, therefore, we conducted experiments in which we treated sillimanite samples 87 under various P-T conditions, and then we used the synchrotron XRD system and 88 89 TEM-energy dispersive spectroscopy (EDS) to analyze the results. In particular, we 90 re-examined the phase relation between sillimanite and mullite with consideration of the 91 degree of Al/Si order in sillimanite by applying these methods to the investigation of 92submicroscopic textures and precise cell-parameter relations. On the basis of our results, we 93 propose a new P-T diagram of the high-temperature region in the Al<sub>2</sub>SiO<sub>5</sub> system.

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#### Sample preparation

97 Starting material

As starting material (hereafter, STR), we used sillimanite crystals from the same sample (collected in Rundvågshetta, East Antarctica; RVH92011102A, Kawasaki et al. 100 1993, 2011) that we used in our previous experiments (Igami et al. 2017, 2018a). The XRD 101 pattern of STR shows only sillimanite peaks, and its cell parameters are a = 7.4867(6), b =102 7.6750(5), and c = 5.7720(5) Å (Igami et al., 2018). Its chemical composition, determined 103 by scanning electron microscopy (SEM)-EDS, is Al<sub>1.99</sub>Fe<sub>0.01</sub>Si<sub>1.00</sub>O<sub>5</sub> (Igami et al. 2017).

104	Under TEM, STR has no characteristic textures such as anti-phase boundary (APB)
105	textures, lamellae, or inclusions (Igami et al. 2018a). The STR crystals were crushed, and
106	impurities were removed under an optical microscope. Then, crystals of adequate size (~2
107	mm across) were picked out for use as single-crystal samples. The rest of the sample was
108	ground to powder, and then powdered samples were loaded into 3-mm-diameter platinum
109	capsules and then both sides of the capsule were squeezed flat for the heating experiment.

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#### 111 Heat treatments

Both the single-crystal and powdered samples were subjected to various temperatures and pressures. A muffle furnace was used for experiments at ambient pressure (1 atm), and an internally heated pressure vessel or piston-cylinder apparatus was used for experiments at high pressure (HP). Hereafter, experimental samples treated at temperature T, pressure P, for time t are designated as S T-P-t (e.g., S 790°C-1atm-700h)

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**Muffle furnace.** Both single-crystal and powdered samples were placed in a platinum 118 119 crucible and heated in a muffle furnace (Nabertherm, LHT02/17 or Koyo, KBF314N1) at 1 atm and temperatures of 790 to 1530 °C for 1 to 1711 h. The temperature was measured 120with a  $Pt_{70}Rh_{30}$ – $Pt_{94}Rh_{6}$  (B-type) thermocouple placed at the top of the sample space in the 121 122 furnace. A digital program controller maintained the run temperature within  $\pm 1$  °C of the nominal value. After heating, the samples were allowed to cool at a cooling rate of  $\sim 10$ 123124°C/min. Igami et al. (2018a) previously observed some of these samples by TEM and used high angular resolution electron channeling X-ray spectroscopy (HARECXS) to determine 125

126 their Al/Si order parameters.

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Internally heated pressure vessel. HP experiments at the pressure of 0.2 GPa were 128performed in an internally heated pressure vessel (KOBELCO, Dr. HIP) at Chiba 129130 University. A powdered sample in a Pt capsule or a single-crystal sample was placed in a platinum wire cage in the internally heated pressure vessel and subjected to temperatures 131132from 1200 to 1400 °C. The pressurizing medium was Ar gas, and the pressure was 133maintained within  $\pm 0.002$  GPa of the nominal pressure of 0.2 GPa during all experiments. 134The run temperature was monitored with a Pt–Pt<sub>87</sub>Rh<sub>13</sub> (R-type) thermocouple in the vessel and maintained within  $\pm 1$  °C of the nominal value. After the heat treatment, samples were 135allowed to cool at a cooling rate of  $\sim 100 \text{ °C}$  /min. 136

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**Piston-cylinder apparatus.** HP experiments at pressures of 0.5–2.5 GPa were performed 138139in a Boyd-England type piston-cylinder apparatus with a 1/2-inch-diameter cylinder and piston (C&T Factory, PG-100) at Kyoto University. Powdered samples in Pt capsules were 140 141 placed in a MgO holder that was surrounded by graphite heaters, Pyrex glass and talc sleeves, and subjected to temperatures from 1300 to 1500 °C. In these experiments, 142143single-crystal samples were not used. The pressure was maintained within  $\pm 0.2$  GPa of the nominal pressure during all experiments. The pressure calibration was previously carried 144 out using silica and enstatite phase transformations (Machida et al. 2017). The run 145temperature was monitored with a Pt–Pt<sub>87</sub>Rh<sub>13</sub> (R-type) thermocouple and a digital program 146147controller (CHINO, KP100c) maintained the temperature within ±1 °C of the nominal value.

148	The thermal gradient of the assembly was previously shown to be limited by an
149	investigation of the run charge of an enstatite-diopside mixture (Machida et al. 2017). After
150	the heat treatment, samples were allowed to cool at a cooling rate of ~100 °C/sec.
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152	Experimental methods
153	Synchrotron powder XRD experiments
154	The powdered samples were analyzed by XRD using the multiple-detector system
155	of Toraya et al. (1996) and the $BL-4B_2$ beamline at the Photon Factory of the High Energy
156	Accelerator Research Organization, Tsukuba, Japan. The segmented intensity data were
157	connected after adjustment for peak shifts and detector sensitivities (Ida 2005). The step
158	interval for scanning was 0.005 or 0.010°, and the diffraction angles ranged from 8.000 to
159	150.000° 20. Because this XRD system is shared by several users, the measurements were
160	performed over several intervals. Before each measurement interval, we therefore measured
161	the Si powder standard (NIST SRM640c) and STR. The peak wavelength of the source
162	X-ray beam was determined by analysis of the diffraction peak profiles of the Si powder
163	(Ida et al. 2003). The wavelengths of the X-ray beam were determined to be 1.747061(11),
164	1.746881(11), 1.746985(10), 1.197419(7), and 1.197318(21) Å. Zero shift and eccentric
165	error for each measurement interval were optimized by analysis of the diffraction peaks of
166	STR.
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168 **TEM and scanning TEM observations** 

169 A focused ion beam (FIB) system (Thermo Fisher Scientific Quanta 200 3DS or

Helios NanoLab G3 CX) was used to prepare ultrathin sections of 16 single-crystal samples 170 for TEM observations. The sections of crystal samples from the muffle furnace and 171internally heated pressure vessel treatments and the powdered samples from the 172piston-cylinder treatment were embedded in epoxy resin and then polished to a smooth 173surface. Using the FIB system, a predefined area  $(20-30 \text{ }\mu\text{m}^2)$  was coated with Pt and then 174a Ga<sup>+</sup> ion gun was used to cut out the surrounding material to a depth of  $\sim 10 \mu m$ . Then the 175176section was cut off, mounted on a TEM grid, and thinned to a thickness of ~150 nm using a Ga<sup>+</sup> ion beam at 30 kV with beam currents of 0.1–3 nA. In the final processing, a Ga<sup>+</sup> ion 177beam at 5 kV with a beam current of 48 pA was used to remove amorphous layers from the 178surface of the sections. 179

180 The samples were studied under a JEOL JEM-2100F transmission electron 181 microscope operated at 200 kV at Kyoto University. TEM images were recorded by CCD cameras (Gatan, Orius 200D and 1000D). Selected area electron diffraction (SAED) 182183 patterns of mullite and sillimanite are similar, but show one important difference. In the 184case that a SAED pattern is indexed based on the standard cell of sillimanite, l = oddreflections are typical for sillimanite, but they are absent for mullite, as also described by 185186 Igami et al. (2018a). Samples were observed by dark field (DF) imaging taken from l = oddreflections of sillimanite as well as by bright field (BF) imaging. 187

Because mullite is slightly enriched in  $Al_2O_3$  compared with sillimanite, chemical analyses were performed by annular dark-field scanning TEM (ADF-STEM) with X-ray mapping using a TEM equipped with annular STEM and EDS detectors (JEOL JED2300T). The acceptable angle of the STEM detector was set to approximately 50–150 mrad to

192	reflect the atomic numbers of the constituent elements (high-angle annular dark-field
193	STEM image). Moreover, a simple k-factor method was used to evaluate the Al/Si ratio of
194	some samples. The k-factor of Al-K to Si-K $(k_{Al/Si})$ was calibrated by using the STEM-EDS
195	results for STR. By the STEM-EDS analysis of 12 different regions of STR, the $I_{(Al-K)}/I_{(Si-K)}$
196	X-ray count ratio converged to an average value of 2.09 with a standard error of 0.02. From
197	this result, the <i>k</i> -factor was determined to be $k_{Al/Si} = 0.96$ , to adjust the Al/Si compositional
198	ratio of STR to 2.00. This k-factor includes the effect of X-ray absorption, but errors caused
199	by the X-ray absorption effect were assumed to be small, because FIB was used to make
200	the thickness of all of the TEM sections almost the same and because the absorption
201	coefficients of Al-K and Si-K are similar.

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#### **Results and Discussion**

#### 205 **Phase identification in high-resolution XRD patterns**

The high-resolution XRD patterns of some heat-treated samples are similar to that 206of STR, but exhibited small new peaks and a broad glass halo, same as Igami et al. (2017). 207208Peak positions of this newly appeared phase and sillimanite are so close to each other that they cannot be separated from their mixtures in laboratory XRD systems. Our XRD 209 210patterns indicate that the newly appeared phases show no diffraction peaks at the positions 211corresponding to the reflections with l = odd in the case of indexing based on the unit cell of sillimanite (Fig. 1, showing the case of S 1476°C-1atm-10h). This indicates that the 212213appeared phase is changed in translational symmetry with half the size of the c axial length 214from sillimanite. It is most likely that mullite was formed from sillimanite with partial melting, although there remains a little possibility that the l = odd reflections are so weak 215216that they cannot be detected in the multiphase patterns and the new phase might be a special mullite with doubled c parameter similar to the "sillimullite" described by Fischer et al. 217(2015). Some XRD patterns of HP-treated samples also included corundum peaks. The only 218 219detected phases in the XRD patterns were sillimanite, mullite, corundum, and glass. All detected crystalline phases in the samples are listed in Tables 1, 2. Clear mullite peaks were 220 detected only in samples heated above 1200 °C. 221

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#### 223 Peak shifts of sillimanite and mullite detected in high-resolution XRD patterns

224 Compared with STR, the XRD patterns of heat-treated sillimanite at 1 atm seemed 225 to show a slight peak shift as the treatment temperature increased (Fig. 2a). These peak shifts, which were detected even though all of the XRD experiments were performed at room temperature, indicate slight changes in the crystal structure of the sillimanite except for thermal expansion or transformation to mullite. In samples treated by both heating and pressure, the XRD patterns also showed a shift in the mullite peak position (Fig. 2b). Thus, mullite seemed to change its crystallographic state as treatment temperature and pressure increased, and the pressure effect was likely more effective than the temperature effect as a cause of the structural change.

We evaluated these peak position differences by calculating the cell parameters of all of the experimental samples from the XRD patterns by least-squares fitting. Before the calculation, we carefully deconvoluted the peaks of sillimanite and mullite using the pseudo-Voigt function, taking advantage of the high angular resolution of the XRD system. The determined cell parameters are listed in Tables 1–2, and details are discussed later.

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#### 239 **TEM observations of microtextures**

240Under TEM, the experimental samples showed various microtextures that were 241different from those of STR (Table 3). For example, TEM images and SAED patterns of 242S 1476°C-1atm-696h, the XRD pattern of which showed only mullite + glass, are shown in Figure 3. When SAED patterns are indexed according to the standard cell of sillimanite, 243244reflections with l = odd (e.g., 021) are extinct, which indicates mullite. In this sample, many 245characteristic glass inclusions elongated in the direction of the *c*-axis of the host mullite 246were observed (Fig. 3a) with characteristic shapes bounded by the {110} prismatic planes of mullite (Fig. 3b). This texture is similar to that reported by previous TEM studies (e.g., 247

Holland and Carpenter 1986; Raterron et al. 1999, 2000), and these inclusions should correspond to the glass halo in the XRD patterns. STEM-EDS analysis using  $k_{Al/Si} = 0.96$  of five different mullite regions without inclusions yielded an average Al/Si ratio = 3.02(10), which is consistent with the normal (3:2) mullite composition:  $3Al_2O_3 2SiO_2$  (Al/Si = 3.00).

252Figure 4 shows TEM images and SAED patterns of S 1450°C-1atm-1150h, which was  $\sim 77\%$  transformed to mullite + glass with  $\sim 23\%$  remaining as sillimanite, as 253254determined by Igami et al. (2017). Two regions are seen in the DF image taken from the l =odd reflection of sillimanite (Fig. 4a): a dark appearing mullite region and a bright 255appearing sillimanite region. The mullite region has the same characteristics as 256257S 1476°C-1atm-696h (Fig. 3), whereas the residual sillimanite region exhibits textures like 258anti-phase boundaries (APB-like texture) with a displacement vector of 1/2[001]. Glass 259inclusions were observed along with these textures, although they were very fine. Holland 260 and Carpenter (1986) described similar APB-like textures in their TEM study.

261APB-like textures visualized by DF-TEM imaging of l = odd reflections were also 262observed in many samples that did not clearly show mullite regions. For example, Figure 5 shows an APB-like texture in S 1373°C-1atm-300h, ~24% of which was transformed to 263264mullite + glass with ~76% remaining as sillimanite, as determined by Igami et al. (2017). In this TEM section, no clear mullite regions are present, but APB-like textures are observed 265266(Fig. 5b). The ADF-STEM image and X-ray map (Figs. 5d, e) clearly show that the regions 267with these textures are more Al rich than the host sillimanite, and they are accompanied by 268fine Si-rich inclusions. This observation indicates that the regions with APB-like texture are not compositionally the same as the host but consist of mullite accompanied by fine 269

SiO<sub>2</sub>-rich glass inclusions. These APB-like mullite textures were not observed in samples heated to less than 1140 °C; this result is consistent with our XRD results and with the mullitization temperature determined by Igami et al. (2017).

Figure 6 shows the TEM images of S 1400°C-1GPa-52h, which is composed of 273274both sillimanite and mullite grains, identified by their SAED patterns. The mullite grains 275have fewer glass inclusions than those in samples heat-treated at 1 atm. STEM-EDS analysis of 10 different mullite regions yielded an average Al/Si ratio of 2.43(6), calculated 276using  $k_{Al/Si} = 0.96$ . This composition is intermediate between sillimanite (Al/Si = 2.00) and 2773:2 mullite (Al/Si = 3.00), but it is within the mullite solid solution series proposed by 278279Cameron (1977). Based on both the SAED and EDS results, this phase is referred to as 280siliceous mullite. The DF image of the l = odd reflection in a sillimanite grain showed 281APB-like textures but fewer glass inclusions than the samples heat treated at 1 atm. This 282result indicates that the regions with APB-like textures are also composed of siliceous mullite with relatively few glass inclusions. These findings support the inference of Hariya 283et al. (1969), deduced by XRD analysis, that siliceous mullite is formed at high pressures. 284

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#### 286 **Cell parameter variation against treatment temperature**

Figure 7 shows the determined cell parameters (Tabs. 1, 2) against treatment temperature. In the figure, the *b* axial length showed the most marked expansion, although the cell parameter that differs most between sillimanite and mullite is the *a* axial length. Igami et al. (2018a) determined that the Al/Si order parameter Q of the tetrahedral site in sillimanite, excluding mullite and glasses in the same sample. The Q value varies from 1

for total order to 0 to total disorder, and is given as Q = 2p - 1 in the case of stoichiometric 292sillimanite, where p is the probability of finding as Al (Si) atom on a Al (Si) site. The 293results of Igami et al. (2018a) shows that Q decreases continuously as the treatment 294temperature increases. Therefore, this characteristic change in the b axial length can be 295296 attributed to Al/Si disordering in sillimanite. We plotted the Q values determined by Igami et al. (2018a) against b axial length (Fig. 8) and found that the relation between Q and b 297tends to be negative and approximately linear, at least for Q > 0.7. According to Igami et al. 298299(2018a), this range of Q corresponds to heating temperatures  $T < \sim 1400$  °C. It is not clear whether the relation is linear for Q < 0.7, corresponding to T > -1400 °C, but temperatures 300 301 in this range are too high to be applicable to natural metamorphic processes. This result indicates that under metamorphic geological conditions, the order parameter Q of 302 sillimanite can be roughly estimated from the *b* axial length of the sillimanite. 303

Sillimanite in HP-treated samples changes with increasing treatment temperature similarly to sillimanite in samples heated at 1 atm (Fig. 7, right panels). This result indicates that the pressure condition does not significantly affect Al/Si disordering and is in agreement with the assumption of Greenwood (1972). Two mullite samples (arrows in Fig. 7a, left panel) with a = ~7.52 Å plot between the sillimanite and mullite groups. These samples are 1 GPa-treated products, and the pressure effect that they exhibit is analyzed in detail below.

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#### 312 Cell parameter variations in relation to treatment pressure

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Comparison of the a, b, and c axial lengths of sillimanite and mullite with

experimental pressure (Fig. 9) shows that increased pressure, but not increased temperature, 314 caused shrinkage of the *a* axial length of mullite, but the *b* and *c* axial lengths did not show 315316 any remarkable change. This result is mostly consistent with the findings of Hariya et al. (1969). The *a* axial length of mullite is acknowledged to increase almost linearly with 317 318 increases in the Al component (e.g., Cameron 1977); thus, Hariya et al. (1969) estimated 319 the chemical composition of HP experimental samples from the relation between a axial 320 length and pressure in analytical results for mullite obtained previously. Our results show 321that the *a* axial length in the HP samples is about intermediate between that of sillimanite 322and 3:2 mullite, consistent with our STEM-EDS chemical analysis results (Al/Si = 2.43(6)) 323 for S 1400°C-1GPa-52h). As Hariya et al. (1969) pointed out, our analytical results also suggest that the SiO<sub>2</sub> component in mullite increases with increasing experimental pressure. 324

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#### 326 Cell parameter relationships between sillimanite and mullite

327 To gain an overview of cell parameter relationships between sillimanite and mullite, Hariya et al. (1969) plotted sillimanite and mullite cell parameters on the V-a plane, where 328 329 a is a axial length and V is unit cell volume. They argued on the basis of the continuity of 330 the plots on the V-a plane that structural change is continuous between sillimanite and mullite. However, as discussed above, expansion of the b axis of sillimanite is caused by 331 Al/Si disordering with increasing temperature, and shrinkage the a axis of mullite is caused 332 by an increased in the SiO<sub>2</sub> component with increasing pressure. To emphasize these two 333 334 factors, we projected data onto the b-a plane where b is b axial length (Fig. 10). The b-a335 projection does not include information on the c axis, but c axis changes caused by

mullitization, Al/Si disordering in sillimanite, or changes in the Al<sub>2</sub>O<sub>3</sub> component of 336 mullite are very small (Figs. 7, 9). The cell parameters of siliceous mullite obtained by the 337 1 GPa treatments in this study do not match with those of "sillimullite" by Fischer et al. 338 (2015) (Fig. 10). Moreover, they do not plot on the tie line connecting ordered sillimanite 339 340 and mullite in the b-a plane projection, whereas the cell parameters of sillimullite is on the tie line reflecting its intermediate feature in crystallography. This result suggests that the 341342structural changes between ordered sillimanite and mullite in heat-treatment are not continuous and not via "sillimullite" structure. Instead, the plots can be divided into two 343 groups: one group consists of phases with various *a* axial lengths but similar *b* axial lengths 344 (b = -7.69 Å) (Group A), and the other consists of phases with various b axial lengths but 345similar *a* axial lengths (a = -7.485 Å) (Group B). Group A consists of mullite with various 346 compositions, and Group B consists of sillimanite with various degrees of Al/Si disorder. If 347 we extend the two lines from Group B and Group A, they cross at around a = -7.49 Å, b =348  $\sim$ 7.69 Å; such a crossover point implies a phase with a stoichiometric Al<sub>2</sub>SiO<sub>5</sub> composition 349 350and disordered Al and Si, that is, completely disordered sillimanite. However, this hypothetical phase requires at least  $T > \sim 1700$  °C and  $P > \sim 2$  GPa, based on the results of 351this study, so it is unsurprising that this phase has never been observed, including in the 352 353 present experiment.

In contrast to this conclusion, Hariya et al. (1969) argued that a complete solid solution series exists between sillimanite and mullite at high pressures and high temperatures. However, their result should be reconsidered in light of the resolution of the XRD system used. Inspection of the XRD patterns shown by Hariya et al. (1969) indicates

that the resolution of their XRD system might have been too low to distinguish between 358 sillimanite and mullite in samples in which they coexisted. For example, they show that a 359 sample treated at 1500 °C and 1.1 GPa for 20 h had cell parameters intermediate between 360 those of sillimanite and mullite. In this study, however, we detected two phases: partially 361 disordered sillimanite ( $b \approx 7.68$  Å) and siliceous mullite ( $a \approx 7.52$  Å) in a sample treated 362 under similar experimental conditions (S 1500°C-1.0GPa-2.5h). In Figure 10, the cell 363 364 parameters of the sample of Hariya et al. (1969) plots almost on a tie line connecting our 365 two detected phases. This result suggests that the sample of Hariya et al. (1969) might have contained both mullite and sillimanite, but they detected them as a single phase. Thus, the 366 367 cell parameters that they reported are likely, in reality, to be weighted means of the cell parameters of separate sillimanite and mullite phases in the sample. 368

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#### 371 Mullitization boundary on *P*–*T* diagram

If there is not a complete solid solution series between sillimanite and mullite under normal geological conditions, as we assert here, a transformation boundary between them should exist on the P-T diagram of the Al<sub>2</sub>SiO<sub>5</sub> system. To estimate the position of this boundary, we plotted the experimental results of this study and the mullitization temperature of 1200 °C at 1 atm, determined by Igami et al. (2017), on the P-T diagram (Fig. 11). In addition, we re-examined representative previous heat-treatment studies.

Holland and Carpenter (1986), who treated sillimanite samples at 1300–1620 °C and 1.8–2.0 GPa, reported abundant APBs or APB-like defects with glass inclusions. They interpreted the cause of these textures to be both continuous enrichment in  $Al_2O_3$  and Al/Sidisordering. In our samples, however, similar microtextures were identified by STEM-EDS to be fine mullite, and their XRD patterns indicated that mullite formed discontinuously from sillimanite. Our results imply a compositional gap between sillimanite and mullite in the SiO<sub>2</sub>-Al<sub>2</sub>O<sub>3</sub> system at 1.8–2.0 GPa, different from the schematic phase diagram proposed by Holland and Carpenter (1986). We consider that the samples that they described as having abundant APBs may have started to transform to mullite (Fig. 11).

387 Raterron et al. (2000) also observed glass inclusions and dislocations in sillimanite treated at 1675 °C and 0.5-3.0 GPa, and they interpreted these textures in terms of a 388 389 continuous solid-solution model between sillimanite and mullite. We agree with their 390 conclusion that mullite has a variable composition at different pressures and temperatures, 391 but we think that a compositional gap exists between sillimanite and mullite. The glass inclusions and other textures observed by them are similar to those observed in the present 392393 HP-samples that show peaks of both sillimanite and mullite in their XRD patterns. We infer 394 that all of their experimental samples had started to transform to mullite (Fig. 11).

Navrotsky et al. (1973) measured the enthalpy of solution of heat-treated samples, and found a distinct decrement of the enthalpy of solution in samples treated at >1400 °C and 1.6–2.3 GPa, compared with unheated sillimanite. They concluded that the enthalpy change was due to Al/Si disordering in stoichiometric sillimanite, but as pointed out by Holland and Carpenter (1986), this result was more likely caused by mullitization. At experimental pressures of 1.6–2.3 GPa, 1400 °C should be in the mullitization region on the P-T diagram (Fig. 11). The mullitization boundary estimated from our experiments is shown by a broad shaded band in Figure 11. Mullitization is a very sluggish reaction, so the dP/dT gradient may be even steeper than the indicated line because the duration of our high-pressure experiments was much shorter than that of the 1 atm experiments of Igami et al. (2017).

406 Figure 11 also shows the mullitization boundaries estimated by calorimetric studies on the *P*–*T* diagram (Holm and Kleppa 1966; Weill 1966; Kiseleva et al. 1983). Although 407 408 our determined boundary is closest to the result of Holm and Kleppa (1966) among the 409 three examples, Anderson and Kleppa (1969) re-evaluated the result of Holm and Kleppa (1966) and determined it to be partly inaccurate. Thus, the consistency between our result 410 411 and that of Holm and Kleppa (1966) might be of little importance. The slope of the 412boundary estimated by this study is steeper than that of Weill (1966) or Kiseleva et al. 413(1983), which may imply expansion of the mullite stability field caused by the effect of pressure-induced compositional changes. Weill (1966) and Kiseleva et al. (1983) calculated 414 415the phase boundaries for mullite with a fixed composition.

416

#### 417 Al/Si order parameter of stoichiometric sillimanite in *P*–*T* diagram

Our XRD results revealed that sillimanite shows a continuous increase in Al/Si disorder with increasing treatment temperatures. Igami et al. (2018a) previously determined the Al/Si order parameter Q of sillimanite in some of the studied samples. These Q values are reliable because precipitated phases (mullite and glasses) were surely excluded from the analytical regions examined by TEM. In addition, our XRD results show that the pressure effect on the Q value may be negligible (Fig. 7). In Figure 12, we show Q values of

sillimanite as a contour on a P-T diagram, where the O values are expressed by the 424Bragg-Williams model as a function of temperature and independent of pressure:  $Q(T_c/T) =$ 425 $1/2 \ln[(1+Q)/(1-Q)]$ , where  $T_c = 1727$  °C (Igami et al. 2018a). Thus, the Q contour line 426is projected vertically onto the *P*-*T* plane. 427428 This figure shows that the Q value at the aluminosilicate triple point is much higher than Q = 0.975. Similarly, the Q value at the sillimanite-andalusite boundary is higher than 429 $\sim 0.95$ . Therefore, the effect of Al/Si disordering on the triple point equilibrium and the 430 sillimanite-andalusite boundary seem to be negligible. In contrast, the sillimanite on the 431432sillimanite-kyanite boundary at high temperatures is in a relatively low ordered state, 433which indicates that the stability field of sillimanite should expand toward that of kyanite.

These results agree with the conclusions of previous theoretical studies (e.g., Saxena 1974).

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#### Implications

The present experimental results imply that submicrometric textures and crystallographic features of sillimanite and mullite may be useful for investigating the thermal history of natural samples, in particular, rocks produced by ultra-high-temperature metamorphism.

For example, Aramaki (1961) reported that sillimanite in pelitic xenoliths from Asama Volcano in Japan have cell parameters a = 7.498(3), b = 7.690(3), and c = 5.797(3)Å, which are near the crossover point shown in Figure 10. Cameron and Ashworth (1972) studied the same Asama sillimanite and reported slightly different cell parameters: a =7.4963(4), b = 7.6851(4), and c = 5.7764(3) Å. Recently, we showed that mullite with a

submicrometric core-rim texture coexists with sillimanite in aluminosilicates from the same 446 locality (Igami et al. 2018b); thus, the previously reported cell parameters can be 447 interpreted as resulting from the presences of double sillimanite and mullite peaks, similar 448 to our interpretation of the results of Hariya et al. (1969). Under this assumption, the b axial 449 450length of sillimanite reported by Cameron and Ashworth (1972) seems to be rather large, an indication that the Al/Si arrangement is considerably disordered. This finding is consistent 451452with the TEM observation of Igami et al. (2018b) that APBs with a displacement vector of 4531/2[001] were abundant in the sample. The cell parameters reported by Aramaki (1961) 454have no clear explanation, but their differences with those reported by Cameron and 455Ashworth (1972) probably reflect a difference in the abundance ratio of sillimanite and 456 mullite. Although the low Al/Si order parameter of this sillimanite cannot be directly associated with temperature in Figure 12, because this low ordered state was probably 457caused by the transformation of mullite to sillimanite (Igami et al. 2018b), the sample might 458459 have reached temperatures around the mullitization boundary.

As in the case of this Asama aluminosilicate example, many interesting characteristics of sillimanite and mullite samples may be overlooked. Investigations of sillimanite that take account of the results of this study can yield new information about thermal histories in high-temperature regions above 1000 °C that is easy to be lost in general.

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555	

556	Table	titles	and	figure	caption
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- 557
- 558 **Tables**
- 559 Table 1.
- 560 Cell parameters of detected crystalline phases in the experimental samples at 1 atm.
- 561

562 Table 2.

563 Cell parameters of detected crystalline phases in the experimental samples at high 564 pressures.

- 565
- 566 Table 3.

567 TEM observation results.

568

569 Figures

570 **Figure 1.** 

Powder X-ray diffraction patterns of STR (lower) and S\_1476°C-1atm-10h (upper). (a) Whole diffraction patterns. All the peaks in STR are reflections of sillimanite. The label of "Sil 210" indicates 210 reflection of sillimanite, which is enlarged in Figure 2. (b)(c) Enlargements of representative peaks. The reflections of 121, 211 and 220 of sillimanite are shown from both STR and S\_1476°C-1atm-10h (solid arrows). On the assumption that the space group of the new appeared phase is *Pbnm* same with sillimanite, 121, 211 and 220 reflection peaks are predicted to appear at  $2\theta = 34.51$ , 34.83 and 37.88°, respectively

578 (dotted arrows). In the pattern of S\_1476°C-1atm-10h, there are a clear peak 579 corresponding to 220 reflection (c), but no peak corresponding to 121 or 211 which is the *l* 580 = odd reflections (b).

581

582 **Figure 2.** 

XRD peak shifts induced by (a) high temperature and (b) high temperature and high 583584pressure treatments. The peaks are labeled with their Miller indices, preceded by sil for sillimanite and mul for mullite. (a) XRD patterns of STR, S 1000°C-1atm-700h, 585S 1200°C-1atm-500h, 586S 1090°C-1atm-1255h, S 1290°C-1atm-60h, 587 S 1373°C-1atm-1711h, and S 1476°C-1atm-10h, arranged in order of treatment 588temperature. (b) XRD patterns of 1373°C-1atm-300h, 1400°C-0.2GPa-19h, and 5891400°C-1.0GPa-2.5h, arranged in order of treatment pressure.

590

591 **Figure 3.** 

TEM images and SAED patterns of S\_1476°C-1atm-696h. (a) BF-TEM image and SAED pattern on the projection of [100]. In case of indexing using sillimanite cell parameters, the l = odd reflections are extinct, which means the samples completely transformation to mullite. (b) BF-TEM image and SAED patterns on the projection of [001]. SAED pattern taken from an inclusion (lower right), shows glass halo.

597

**598 Figure 4**.

599 S/TEM-EDS images of S\_1450°C-1atm-1150h. (a) DF-TEM image of the section taken

- 600 from the g = 101 reflection of sillimanite. (b) SAED pattern of the same area. (c) 601 ADF-STEM images. (d) X-ray map obtained by dividing  $I_{AI-K}$  by  $I_{Si-K}$ .
- 602

603 **Figure 5.** 

- 604 S/TEM-EDS images of S\_1373°C-1atm-300h. (a) BF-TEM image and (b) DF-TEM image
- taken from the g = 021 reflection. (c) SAED pattern of the same area. (d) ADF-STEM
- 606 image. (e) X-ray map obtained by dividing  $I_{AI-K}$  by  $I_{Si-K}$ .
- 607
- 608 **Figure 6.**
- 609 TEM images and SAED patterns of S 1400°C-1GPa-52h. (a) BF-TEM image of a section 610 containing two grains. (b) Enlarged BF-TEM image of the region enclosed by a dotted 611 rectangle in (a) and the SAED pattern of the same area, which shows a mullite pattern. There are fewer glass inclusions than in the samples heat treated at 1 atm. (c) Enlarged BF-612 613 and DF-TEM images of the region enclosed by a second dotted rectangle in (a) and the 614 SAED pattern of the same area. The SAED pattern shows the l = odd reflections of sillimanite, and the DF image is taken from the g = 211 reflection of sillimanite. In this 615 616 grain, an APB-like texture with few glass inclusions was observed.
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618 Figure 7.
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(a) a, (b) b, and (c) c axial lengths of sillimanite and mullite in relation to treatment temperature. To simplify comparison with sillimanite, the c axis of mullite is treated as the twice length. The panels on the right are enlargements of the areas between the dashed horizontal lines in the left panels. Arrows in the left panel of (a) indicate mullite in the 1GPa treatment product.

624

625 **Figure 8.** 

626 Order parameter Q values from Igami et al. (2018a) plotted against b axial lengths 627 determined in this study; Q and b tend to be negatively correlated.

628

629 **Figure 9.** 

(a) a, (b) b, and (c) c axial lengths of sillimanite and mullite plotted against experimental
pressure.

632

633 **Figure 10.** 

Projection of our results on the b-a plane. A continuous relationship between ordered 634 635 sillimanite and mullite is not observed. Instead, the plots can be divided into Group A and Group B with a hypothetical crossover point at a = -7.49 Å, b = -7.69 Å. The 636 1500°C-1.1GPa-20h product reported by Hariya et al. (1969) (rhombus), lies roughly on the 637 638 tie line (dotted line) between the two phases that we detected in a similar experimental sample in this study (S 1500°C-1.0GPa-2.5h, shown by large circle and large square). If 639 640 we assume that the cell parameters of Asama sillimanite (Cameron and Ashworth 1972) are 641 weighted means of sillimanite and mullite parameters, then the *b* axial length of sillimanite seems to be relatively large compared with the STR of this study, indicating a disordered 642Al/Si arrangement. 643

644

#### 645 **Figure 11.**

P-T diagram showing the phase relation between sillimanite and mullite in the results of 646 this study and previous studies. In this study, open circles indicate that mullite is present, 647 648 and filled circles indicate that it is absent. Half-filled circles indicate that presence of mullite is slight or unclear. The mullitization temperature at 1 atm (1200 °C) determined by 649 reaction kinetics analysis (Igami et al., 2017) is plotted by a cross. Previous studies reported 650 651 that some experimentally heated samples show intermediate feature between sillimanite and mullite (hatched symbols), but their samples may have coexistence of mullite and 652 sillimanite, according to comparison of the original description with our results. The broad 653654 shaded band shows the mullitization boundary estimated in this study. Mullitization 655 boundaries estimated by previous studies are also shown.

656

#### 657 Figure 12.

*P-T* diagram of the Al<sub>2</sub>SiO<sub>5</sub> system showing the contour of the *Q* value of sillimanite. Phase boundaries between kyanite, andalusite, and sillimanite follow Holdaway (1971). The *Q* values are expressed as a function of temperature, and independent of pressure, in accordance with the Bragg-Williams model (Igami et al. 2018a):  $Q(T_c/T) = 1/2 \ln[(1+Q)/((1-Q))]$ , where  $T_c = 1727$  °C. The stability field of sillimanite should expand toward that of kyanite with increasing temperature because of Al/Si disordering (expressed schematically by the curved dashed line).

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Sample	Sillimanite			Mullite		
Name	a (Å)	b (Å)	<i>c</i> (Å)	a (Å)	b (Å)	<i>c</i> (Å)
S_790°C-1atm-700h	7.4850(3)	7.6742(2)	5.7719(3)	-	-	-
S_890°C-1atm-700h	7.4855(2)	7.67446(1 3)	5.7724(2)	-	-	-
S_1000°C-1atm-700h	7.4859(2)	7.67446(1 2)	5.7722(2)	$\Delta$	Δ	Δ
S_1040°C-1atm-700h	7.4858(2)	7.67490(1 1)	5.7722(2)	$\Delta$	Δ	Δ
S_1090°C-1atm-1255h	7.4861(2)	7.67497(1 3)	5.7720(2)	$\Delta$	Δ	Δ
S_1140°C-1atm-1512h	7.4867(2)	7.67586(1 1)	5.7722(2)	$\Delta$	Δ	Δ
S_1200°C-1atm-500h	7.4861(2)	7.67566(1 5)	5.7717(2)	$\Delta$	Δ	Δ
S_1240°C-1atm-144h	7.4869(2)	7.67642(1 2)	5.7717(2)	Δ	Δ	Δ
S_1239°C-1atm-785h	7.4877(2)	7.67672(1 3)	5.7720(3)	7.5403(6)	7.6880(9)	2.8852(6)
S_1290°C-1atm-60h	7.4865(2)	7.67698(1 3)	5.7717(2)	7.5513(10)	7.6923(8)	2.8867(8)
S_1373°C-1atm-70h	7.4874(2)	7.6788(2)	5.7711(2)	7.5441(5)	7.6905(3)	2.8846(3)
S_1373°C-1atm-300h	7.4873(2)	7.67968(1 3)	5.7718(2)	7.5423(4)	7.6916(2)	2.8855(2)
S_1373°C-1atm-1711h	7.4884(2)	7.6809(2)	5.7717(3)	7.5385(4)	7.6912(3)	2.8852(2)
S_1476°C-1atm-1h	7.4873(2)	7.6810(2)	5.7713(2)	7.5480(4)	7.6889(6)	2.8853(4)
S_1476°C-1atm-10h	7.4886(2)	7.68245(1 2)	5.7719(2)	7.5390(5)	7.6914(3)	2.8858(3)
S_1476°C-1atm-90h	7.4903(4)	7.6835(3)	5.7707(5)	7.5440(2)	7.69141(15	2.88502(11)
S_1476°C-1atm-696h	-	-	-	7.5408(2)	7.6919(2)	2.88457(11)
S_1530°C-1atm-5h	7.4879(2)	7.6828(2)	5.7712(2)	7.5496(3)	7.6888(3)	2.8853(2)
S_1530°C-1atm-20h	7.4898(3)	7.6854(3)	5.7714(3)	7.5484(4)	7.6902(3)	2.8856(2)
S_1530°C-1atm-60h	-	-	-	7.5436(5)	7.6927(3)	2.8848(3)

Note: O, detected;  $\Delta$ , slightly detected; -, not detected

#### Corundum

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Sample	Sillimanite		-	Mullite		
Name	a (Å)	b (Å)	<i>c</i> (Å)	a (Å)	<i>b</i> (Å)	<i>c</i> (Å)
S_1200°C-0.2GPa-45h	7.4869(2)	7.67690(1 3)	5.7714(2)	Δ	Δ	Δ
S_1300°C-0.2GPa-41.5h	7.4882(2)	7.6799(2)	5.7710(3)	7.5374(7)	7.6887(5)	2.8856(5)
S_1400°C-0.2GPa-19h	7.4884(2)	7.68184(1 1)	5.7703(3)	7.5401(6)	7.6894(5)	2.8833(5)
S_1400°C-1GPa-2.5h	7.4866(2)	7.68184(1 3)	5.7701(4)	7.5200(3)	7.6906(2)	2.8840(3)
S_1500°C-1GPa-2.5h	7.4874(2)	7.68280(1 4)	5.7700(4)	7.5219(5)	7.6901(3)	2.8843(5)
S_1300°C-2.5GPa-24h	7.48767(15	7.67745(1 1)	5.7717(2)	-	-	-
S_1400°C-2.4GPa-22h	7.4913(2)	7.6806(2)	5.7716(2)	-	-	-

Note: O, detected;  $\Delta$ , slightly detected; -, not detected

Corundum	
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Sample name (Section	Glass	APB-like	Mullite region
S 1530°C-1 atm-5h (1)	©	©	0
S_1476°C-1 atm-696h (1)	Ø	-	Ø
S_1476°C-1 atm-90h (1)	Ø	-	Ø
S_1476°C-1 atm-10h (1)	Ø	Ø	0
S_1476°C-1 atm-1h (1)	0	0	0
S_1476°C-1 atm-1h (2)	0	0	-
S_1450°C-1 atm-1150h (1)	Ø	Ø	Ø
S_1373°C-1 atm-1711h (1)	0	0	-
S_1373°C-1 atm-1711h (2)	Ø	Ø	-
S_1373°C-1 atm-300h (1)	Ø	Ø	-
S_1373°C-1 atm-300h (2)	0	Δ	-
S_1373°C-1 atm-300h (3)	-	-	-
S_1373°C-1 atm-70h (1)	Δ	Δ	-
S_1290°C-1 atm-60h (1)	0	0	-
S_1290°C-1 atm-60h (2)	0	-	0
S_1239°C-1 atm-785h (1)	$\bigtriangleup$	Δ	-
$5_{1140}$ C-1 atm-1312n	-	-	-
S_1140°C-1 atm-1512h (2)	-	-	-
S_1140°C-1 atm-1512h	-	-	-
S_1090°C-1 atm-1255h (1)	-	-	-
S_1400°C-0.2 GPa-19h (1)	Ø	Ø	-
S_1400°C-1.0 GPa-52h	Δ	0	Ø
S_1400°C-2.4 GPa-22h	-	0	-
(1) S_1400°C-2.4 GPa-22h (2)	Δ	0	-

S_1400°C-2.4 GPa-22h (3)	Δ	-	-
Starting material (1)	-	-	-
Starting material (2)	-	-	-
-	-		

Note:  $\bigcirc$ , abundantly observed;  $\bigcirc$ , observed;  $\triangle$ , rarely observed; -, never





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Figure 8

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